

**Notice of References Cited**Application/Control No.  
09/555,908Applicant(s)/Patent Under  
Reexamination  
TAKEMURA ET AL.Examiner  
Devona E. FaulkArt Unit  
2644

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,084,970	07-2000	Aarts et al.	381/17
	B	US-5,844,993	12-1998	Iida et al.	381/18
	C	US-6,175,489	01-2001	Markow et al.	361/683
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06165298 A	06-1994	Japan	HAYAKAWA et al.	H04S 01/00
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.